



603 Pin Socket

Design Guidelines



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1. Introduction

1.1. Objective:

This document defines a ZIF (Zero Insertion Force) socket intended for workstation and server platforms based on future Intel microprocessors. The socket provides I/O, power and ground contacts. The socket must be low cost, low risk, robust, high volume manufacturable (HVM), and multi-sourceable. The socket has 603 contacts with solder balls/surface mount features for surface mounting with the motherboard. The 603 Pin Socket contacts have 50mil pitch with regular pin array, to mate with 603 pins on the Intel® Xeon™ processor package.

1.2. Purpose:

To define functional, quality, reliability, and material (that is, visual, dimensional and physical) requirements and design guidelines of the 603 Pin Socket. To provide a 603 Pin Socket which meets or exceeds applicable standards and Intel manufacturing criteria. The 603 Pin Socket must be surface mountable and meet all the reliability requirements.

1.3. Scope:

This design guideline applies to all 603-pin ZIF sockets purchased to the requirements of this design guideline.



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2. Processor Pin Field Description:

Information provided in this section is to ensure dimensional compatibility of the 603 Pin Socket with that of the Intel® Xeon™ processor. The processor must be inserted into the 603 Pin Socket with zero insertion force when the socket is not actuated.

2.1. Processor pin field without Heatsink:

The outline of the processor that can be used with the 603 Pin Socket is illustrated in Figure 9-1 (Appendix A.1). This drawing does not include potential heat sinks since these are used at the OEM's discretion. Specific details can be obtained from *Intel® Xeon™ Processor Thermal Design Guidelines*, consult your Intel field representative to obtain this document.

2.2. Pin Dimensions:

Details of the pin dimensions are shown in Figure 9-3 (Appendix A.3). All dimensions are Metric. Note that the pin diameter may vary by +0.05/-0.025mm and effective pin length by ± 0.076 mm. The pin base material is Kovar. The plating material and thickness is 8 μ in of Au over 80 μ in of Ni. The package Critical To Function (CTF) Dimensions are presented in Table 2-1.

Table 2-1: Package Critical To Function (CTF) Dimensions

Dimension	Minimum mm	Maximum mm
Shoulder Diameter (Land Solder Fillet Shoulder Inclusion)	N/A	0.76 max
Pin Diameter	0.28	0.36
Shoulder Diameter Protrusion (Land Solder Fillet Shoulder Inclusion)	N/A	0.254
Pin Socketable Length	1.96	2.11
Pin TP	N/A	0.254
Flatness of Processor	N/A	0.007mm/mm ²



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3. Mechanical Requirements

3.1. Pin-Out and Orientation Diagram:

The pin-out for the 603 Pin Socket is shown in Figure 9-2 (Appendix A.2). This diagram is viewed from the TOP of the SOCKET.

3.2. Mechanical Supports:

A retention system needs to isolate any load in excess of 50lbf, compressive, from the socket during the shock and vibration conditions outlined in Sections 5. The socket must pass the mechanical shock and vibration requirements listed in Sections 5 with the associated heatsink and retention mechanism attached. Socket can only be attached by the 603 contacts to the motherboard. No external (i.e. screw, extra solder, adhesive....) methods to attach the socket are acceptable

3.3. Materials:

3.3.1. Socket Housing:

Thermoplastic or equivalent, UL 94V-0 flame rating, temperature rating and design capable of withstanding the reflow solder process per Section 3.6.2.

3.3.2. Color:

The color of the socket can be optimized to provide the contrast needed for OEM's pick and place vision systems. The base and cover of the socket may be different colors as long as they meet the above requirement.

3.3.3. Markings:

3.3.3.1. Name:

603 Pin Socket (Font type is Helvetica - 16 point Bold).

This mark shall be molded or Laser Marked into the processor side of the socket housing.

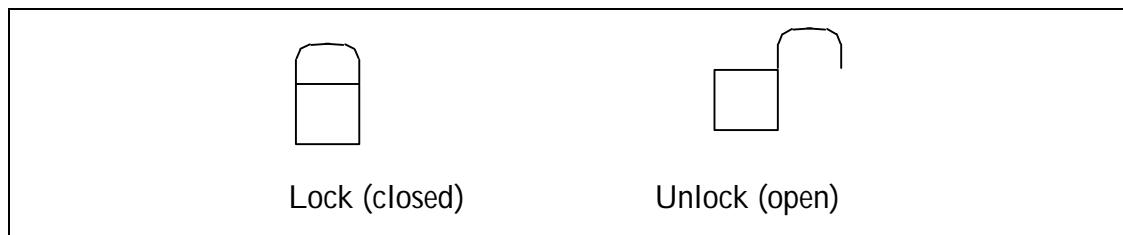
Manufacturer's insignia (font size at supplier's discretion).

This mark will be molded or Laser Marked into the socket housing. Both marks must be visible when first seated in the motherboard. The marks must withstand the reflow solder process of Section 5.4 and the solvent resistance test in of Section 5.3. Any requests for variation from this marking requires a written description (detailing size and location) to be provided to Intel for approval.



3.3.3.2. Lock (closed) and Unlock (open) Markings

For lock an unlock positions on the socket they are to be marked with the universal symbol of the locked and unlocked pictures. Clear indicator marks must be located on the actuation mechanism that identifies the lock (closed) and unlock (open) positions of the cover as well as the actuation direction. These marks should still be visible after a package is inserted into the socket.



3.3.3.3. Lot Traceability:

Each socket will be marked with a part number and lot identification code that will allow traceability of all components, date of manufacture (year and week), and assembly location. This mark can be an ink mark or a laser mark but must be able to withstand a temperature of 240°C for 40sec (minimum) per Section 3.6.2 and must pass the solvent resistance test in Section 5.3. The mark must be placed on a surface that is visible when mounted on a printed circuit board. In addition, this identification code must be marked on the exterior of the box in which the units ship.

3.3.3.4. Socket Size:

The socket size must meet the dimensions as shown in Figure 9-4 (Appendix A.4) and Figure 9-5 (Appendix A.5), allowing full insertion of the pins in the socket, without interference between the socket and the pin field. The processor (not the pin shoulder) must sit flush on the socket. The 603 Pin Socket and actuation area must fit within the keep-in zone defined in Figure 9-5 (Appendix A.5).

3.3.3.5. Socket/Processor pin field Movement:

The socket shall be built so that the processor pin field displacement will not exceed 1.52mm (in the y-direction, i.e. North-South) during engagement and disengagement.

3.3.3.6. Orientation in Packaging and Shipping and Handling:

Packaging media needs to support high volume manufacturing.

3.3.4. Contact Characteristics:

3.3.4.1. Number of Contacts:

Total number of contacts: 603.

3.3.4.2. Base Material:

High strength copper alloy.

3.3.4.3. Contact Area Plating:

76.2 μ mm (min) gold plating over 127 μ mm (min) nickel underplate in critical contact areas (area on socket contacts where processor pins will mate). No contamination by solder in the contact area is allowed during solder reflow.

3.3.4.4. Solder Ball/Surface Mount Feature Attachment Area Plating:

381 μ mm (min) Tin/Lead (typically 85 \pm 5Sn/15Pb).

3.3.4.5. Solder Ball/Surface Mount Feature Characteristics:

Tin/Lead (63/37 \pm 0.5% Sn),

3.3.4.6. Lubricants:

Final assembly shall not have any lubricants on the socket contacts.

3.3.5. Environmental Concerns Requirements:

Cadmium shall not be used in the painting or plating of the socket. CFCs and HFCs shall not be used in manufacturing the socket.

3.4. Visual Inspection:

The visual inspection criteria will be OEM specific.

3.5. Socket Manufacturability Requirements:

3.5.1. Lever Design Requirements

- Lever closed direction – right
- Actuation direction called out in Figure 9-5 (Appendix A.5)
- 135° lever travel max
- Pivot point in the center of the actuation area on the top of the socket (see Figure 9-6 - Appendix A.6)
- Keep in drawing Figure 9-6 - Appendix A.6

3.5.2. Socket Engagement/Disengagement Force:

Less than a force of 4.5Kg or a torque of 112mm-Kg (e.g. using a 25.4mm diameter screwdriver palming the screwdriver "Power Grip" not finger tips) to engage/disengage using the actuation tool, movement of the cover limited to the plane parallel to the motherboard. The processor package must not be utilized in the actuation of the socket. The actuation tool must be readily available on the open market. Any



actuation must meet or exceed SEMI S8-95 Safety Guidelines for Ergonomics/Human Factors Engineering of Semiconductor Manufacturing Equipment, example Table R2-7 (Maximum Grip Forces)

3.5.3. Visual Aids:

The socket top will have markings identifying open and closed positions for the handle.

The socket top will have markings identifying Pin 1. This marking will be represented by a triangular symbol. See Figure 9-5 (Appendix A.5).

3.5.4. Equipment Pick and Place:

The preferred method to transfer surface mount connectors from the packaging media to the board assembly is to use a vacuum actuated nozzle. Vacuum cup area on the connector needs to be available to securely hold the part during transfer and placement. Considerations for the size of the area include connector mass, mass symmetry, acceleration/deceleration transfer rate, angular momentum, and location precision of the connector in the packaging media. Typically, a 10mm diameter vacuum nozzle can support a maximum load of 15g.

3.5.5. Solderability Test:

Must pass 95% coverage per solder ball/surface mount feature.

3.5.6. Socket BGA Co-Planarity:

The co-planarity requirement for all solderballs or surface mount features on the underside of the socket is defined as follows.

Solder balls must have a co-planarity of 0.20mm maximum over the entire ball field.

Leads must have a co-planarity of 0.15mm maximum over the entire field.

3.5.7. Solder Ball/Surface Mount Feature True Position:

The solder balls/surface mount features have a 0.41mm true position requirement with respect to Datum A, B, and C see Figure 9-5 (Appendix A.5).

3.6. Assembly Requirements to the Motherboard:

3.6.1. Surface Mountable:

The socket must be a surface mount socket design and able to mount to pads and VIP.

3.6.2. Reflow Characteristics:

Max Temperature: 240°C

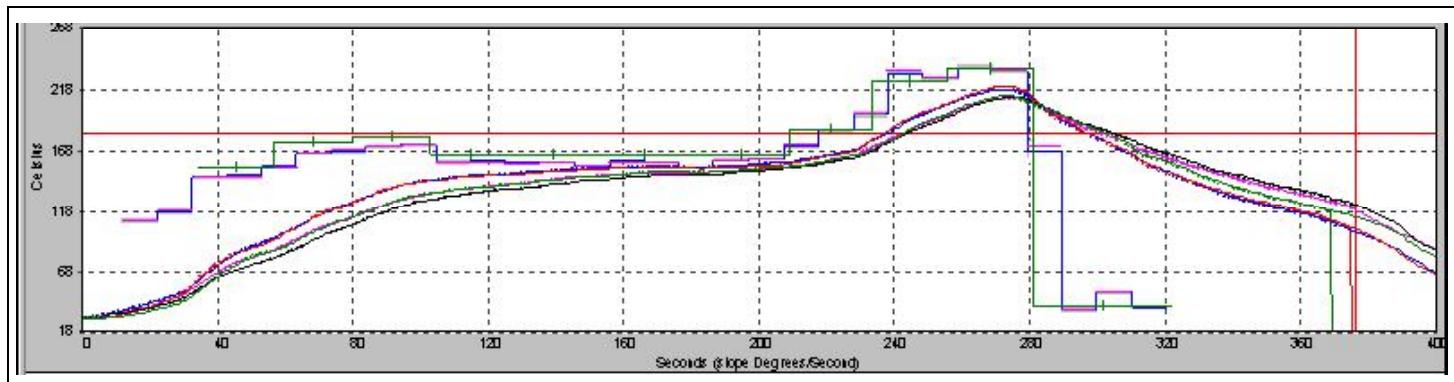


Figure 3-1: Typical Reflow Profile for 63Sn/37Pb solder

3.6.3. Overall Assembly Sequence:

Step 1 - Mount 603 Pin Socket to the motherboard using a surface mount process

Step 2 - Install retention mechanism

Step 3 - Install processor

Step 4 - Install heat sink

3.7. Critical To Function Dimensions:

The 603 Pin Socket shall accept a 603 pin processor pin field. All dimensions are Metric. Asymmetric features are designed to properly align the socket to the motherboard and prevent the socket from being assembled incorrectly to the motherboard. The socket dimensions are shown in Figure 9-4 (Appendix A.4) and Figure 9-5 (Appendix A.5). Figure 9-2 (Appendix A.2) shows the outline of the processor pin field.

Critical to function dimensions are identified in Table 3-1. Each of the dimensions must meet the requirements given in Table 3-1. These dimensions will be verified as part of the validation process. Also, supplier will provide and maintain Critical Process Parameters controlling these CTFs or will provide direct measurements to meet ongoing quality requirements.

Table 3-1: Socket Critical To Function Dimensions

Dimension	Index	Minimum mm	Maximum mm
Socket Length			63.75
Socket Width		53.70	54
Socket Height (Interposer surface from MB)		5.38	6.15
Assembled Cover Flatness		N/A	0.20
Co-planarity		N/A	
Lead / Surface Mount Feature			0.15



Dimension	Index	Minimum mm	Maximum mm
Solder Ball			0.20
True Position of Balls		N/A	0.41
True Position of Lead / Surface Mount Feature (X,Y)		N/A	0.41
Actuation Distance (Cover Travel)		N/A	1.52
Cover Thickness		Design Specific	Design Specific
Cover Hole Diameter (Must guarantee ZIF)		Design Specific	Design Specific
Cover Hole Virtual Condition (Pattern Locating)		0.30	N/A
Cover Hole Virtual Condition (Feature Relating)		Design Specific	N/A
Contact Gap		Design Specific	Design Specific
Contact True Position		Design Specific	Design Specific
Base Flatness		Design Specific	Design Specific
Through Cavity Y		13.21	N/A
Through Cavity X		14.22	N/A
Au Location		Design Specific	Design Specific
Au Thickness		76.2 μ mm	N/A
Ni Thickness		127 μ mm	N/A

4. Electrical Requirements

Table 4-1: Electrical Requirements for Sockets

*1	Mat11 loop inductance, Lloop	<4.33nH	Refer to Table 4-2 section 1
2	Mated partial mutual inductance, L	NA	Refer to Table 4-2 section 2a
*3	Maximum mutual capacitance, C	<1pF	Refer to Table 4-2 section 3
4	Maximum Ave Contact Resistance	$\leq 25m\Omega$	Refer to Table 4-2 section 4 Refer to Section 4.1 for more detail
5	Measurement frequency(s) for Pin-to-Pin/Connector-to-Connector capacitance.	400MHz	
6	Measurement frequency(s) for Pin-to-Pin/Connector-to-Connector inductance.	1GHz	
7	Dielectric Withstand Voltage	360 Volts RMS	
8	Insulation Resistance	800 M Ohms	
9	Contact Current Rating	Read & record	

Table 4-2: Definitions

1	Mated loop inductance, Lloop Refer to Table 4.1-1	The inductance calculated for two conductors, considering one forward conductor and one return conductor.
2a	Mated mutual inductance, L Refer to Table 4.1-2	The inductance on a conductor due to any single neighboring conductor.
3	Maximum mutual capacitance, C Refer to Table 4.1-3	The capacitance between two pins/connectors.
4	Maximum Average Contact Resistance Refer to Table 4.1-4	The max average resistance target is originally derived from max resistance of each chain minus resistance of shorting bars divided by number of pins in the daisy chain. This value has to be satisfied at all time. Thus, this is the spec valid at End of Line, End of Life and etc. <u>Socket Contact Resistance:</u> The resistance of the socket contact, interface resistance to the pin, and the entire pin to the point where the pin enters the interposer; gaps included.
5	Measurement frequency(s) for capacitance.	Capacitively dominate region. This is usually the lowest measurable frequency. This should be determined from the measurements done for the feasibility.
6	Measurement frequency(s) for inductance.	Linear region. This is usually found at higher frequency ranges. This should be determined from the measurements done for the feasibility.



Socket electrical requirements are measured from the socket-seating plane of the processor test vehicle (PTV) to the component side of the socket PCB to which it is attached. All specifications are maximum values (unless otherwise stated) for a single socket pin, but includes effects of adjacent pins where indicated. Pin and socket inductance includes exposed pin from mated contact to bottom of the processor pin field.

4.1. Electrical Resistance:

Figure 4-1 and Figure 4-2 show the proposed methodology for measuring the final electrical resistance. The methodology requires measuring interposer flush-mounted directly to the motherboard fixtures, so that the pin shoulder is flush with the motherboard, to get the averaged jumper resistance, R_{jumper} . The R_{jumper} should come from a good statistical average of 30 interposer fixtures flush mounted to a motherboard fixture. The same measurements are then made with an interposer fixture mounted on a supplier's socket, and both are mounted on a motherboard fixture; this provides the R_{Total} . The resistance requirement, R_{Req} , can be calculated for each chain as will be explained later.

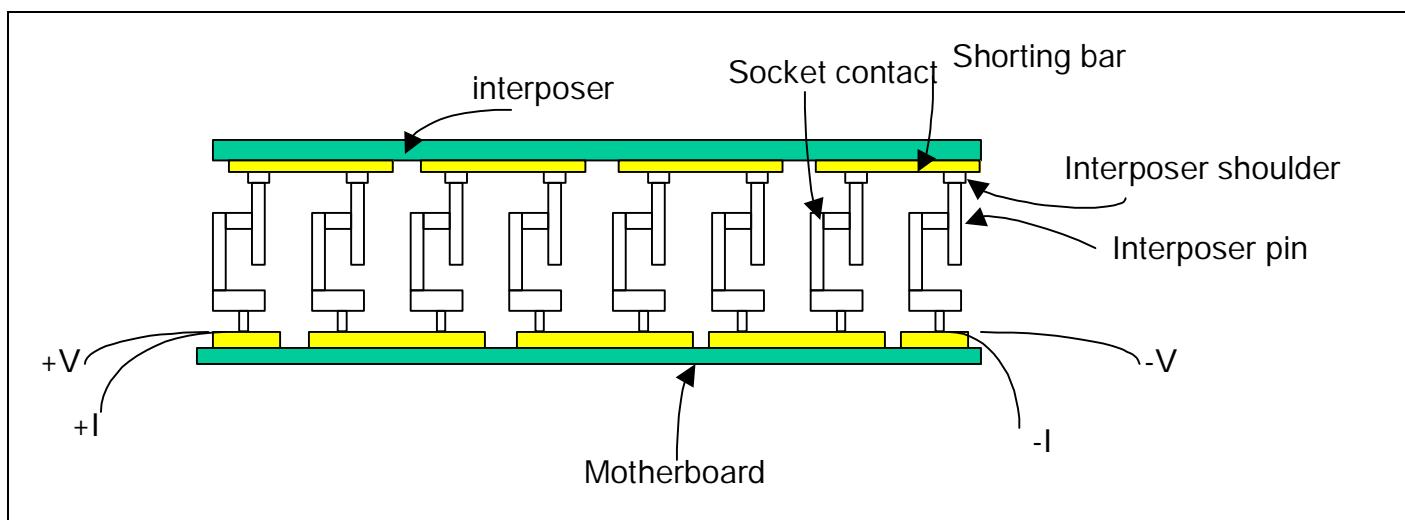


Figure 4-1: Methodology for Measuring Total Electrical Resistance.

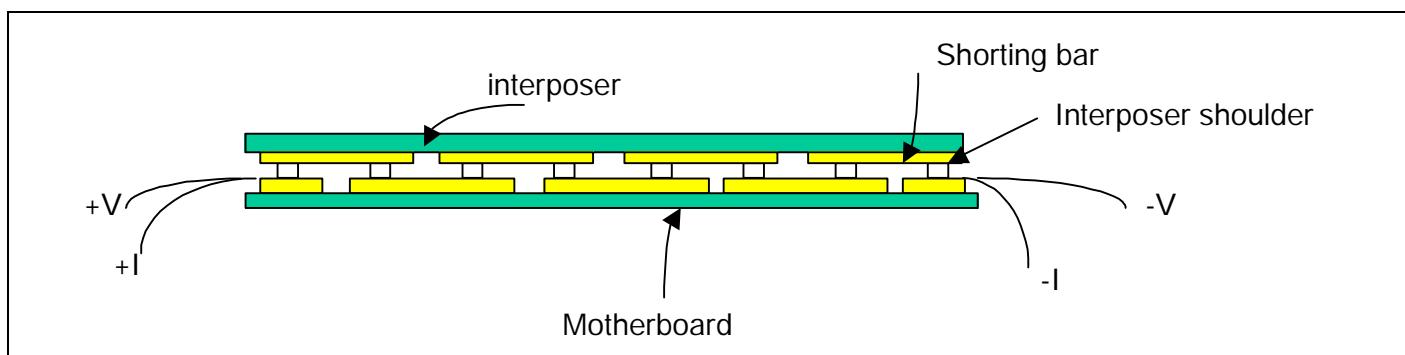


Figure 4-2: Methodology for Measuring Electrical Resistance of the Jumper

Figure 4-3 shows the resistance test fixtures separately and superimposed. The upper left figure (blue traces) is the interposer. The upper right figure (red traces) is the baseboard. There are 31 daisy chain configurations on resistance test board. The bottom center view is the two parts superimposed. Table 4-3 shows these configurations with the number of pins per each chain and netlist.

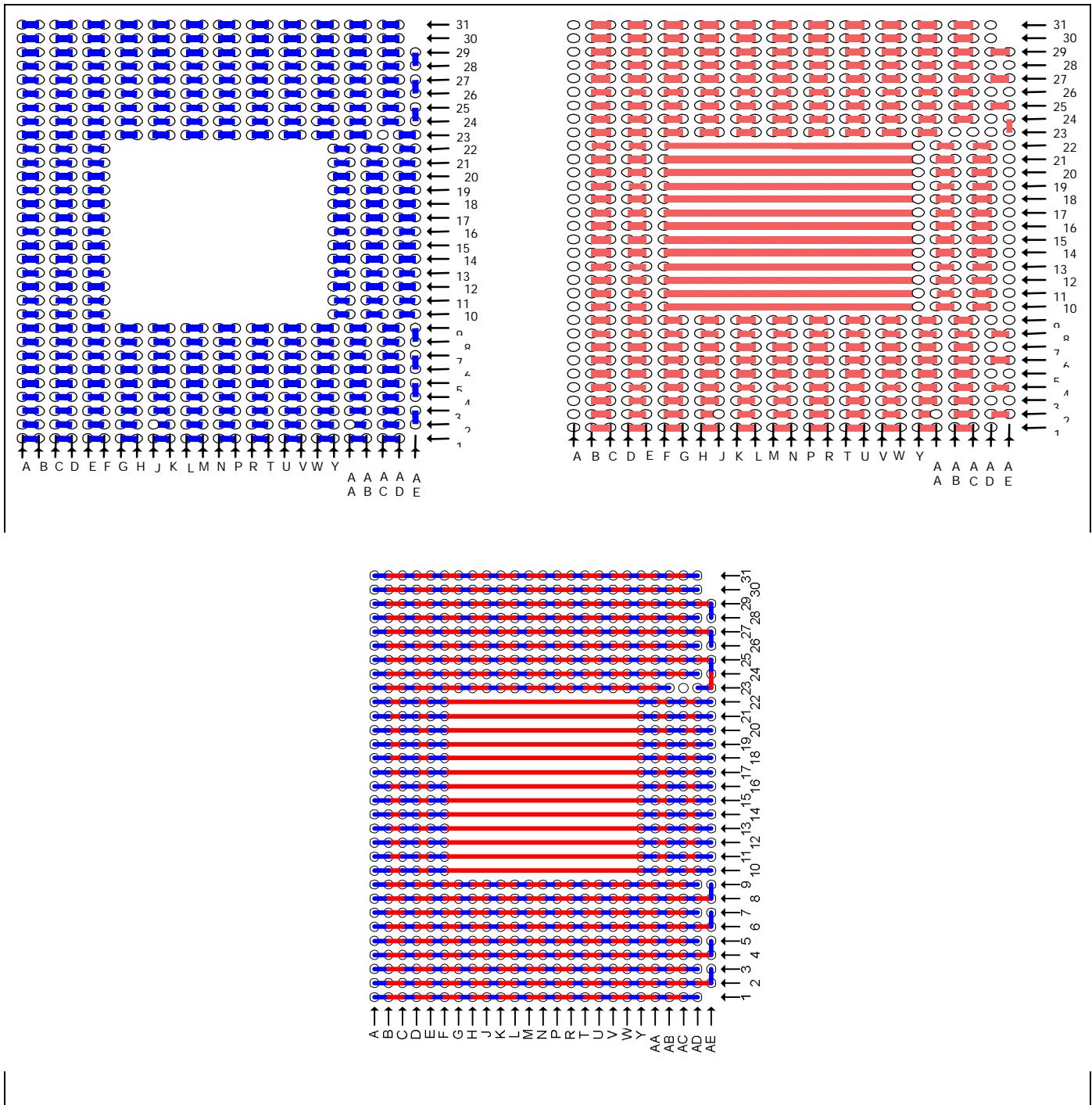


Figure 4-3: Electrical Resistance Fixtures superimposed.



Table 4-3

Daisy Chain	# of pins per chain	DC Endpoints		Edgefingers: Hi		Edgefingers: Low	
		Hi	Low	+I	+V	-V	-I
1	24	A1	AD1	A61	A62	A84	A85
2	26	A2	AE3	A59	A60	A88	A89
3	24	A3	AD3	A57	A58	A86	A87
4	26	A4	AE5	A55	A56	A92	A93
5	24	A5	AD5	A53	A54	A90	A91
6	26	A6	AE7	A51	A52	A96	A97
7	24	A7	AD7	A49	A50	A94	A95
8	26	A8	AE9	A47	A48	A100	A101
9	24	A9	AD9	A45	A46	A98	A99
10	12	A10	AE10	A43	A44	A102	A103
11	12	A11	AE11	A41	A42	A104	A105
12	12	A12	AE12	A39	A40	A106	A107
13	12	A13	AE13	A37	A38	A108	A109
14	12	A14	AE14	A35	A36	A110	A111
15	12	A15	AE15	A33	A34	A112	A113
16	12	A16	AE16	A31	A32	A114	A115
17	12	A17	AE17	A29	A30	A116	A117
18	12	A18	AE18	A27	A28	A118	A119
19	12	A19	AE19	A25	A26	A120	A121
20	12	A20	AE20	A23	A24	A122	A123
21	12	A21	AE21	A21	A22	A124	A125
22	12	A22	AE22	A19	A20	A126	A127
23	22	A23	AB23	A17	A18	A128	A129
24	24	A24	AD24	A15	A16	A132	A133
25	28	A25	AD23	A13	A14	A130	A131
26	24	A26	AD26	A11	A12	A136	A137
27	26	A27	AE26	A9	A10	A134	A135
28	24	A28	AD28	A7	A8	A140	A141
29	26	A29	AE28	A5	A6	A138	A139
30	24	A30	AD30	A3	A4	A142	A143
31	24	A31	AD31	A1	A2	A144	A145

4.2. Determination of Maximum Electrical Resistance:

This section provides a guideline for the instruments used to take the measurements.

Note: The instrument selection should consider the guidelines in EIA 364-23A.

- a) These measurements use a 4-wire technique, where the instruments provide two separate circuits. One is a precision current source to deliver the test current. The other is a precision voltmeter circuit to measure the voltage drop between the desired points.
- b) These separate circuits can be contained within one instrument, such as a high quality micro-ohmmeter, a stand-alone current source and voltmeter, or the circuits of a data acquisition system.
- c) Measurement accuracy in Ω is specified as $\pm 0.1\%$ of reading, or $\pm 0.1 \text{ m } \Omega$, whichever is greater. The vendor is responsible for demonstrating that their instrument(s) can meet this accuracy.
- d) Automation of the measurements can be implemented by scanning the chains through the edge or cable test connector using a switch matrix. The matrix can be operated by hand, or through software.
- e) Measure R_{Total} for each daisy chain of “interposer + socket + motherboard” unit.
- f) Measure R_{jumper} for each daisy chain of 30 “interposer + motherboard” units. Calculate \bar{R}_{jumper} for each daisy chain (There is 30 data for each daisy chain).
- g) For each socket unit, calculate

$$R_{\text{Req}} = \frac{R_{\text{Total}} - \bar{R}_{\text{jumper}}}{N}$$

R_{Req} is the average contact resistance for socket pin.

4.3. Inductance:

The bottom fixture for the inductance measurement is a ground plane on the secondary side of the motherboard with all pins grounded. The component side of the socket PCB does not contain a plane. The top fixture is the interposer, which contains pins that will connect to the socket. Figure 4-4 shows the inductance measurement fixture cross-section and the inductance measurement methodology. The first figure shows the entire assembly. The second figure shows the assembly without the socket; the socket-seating plane of the interposer is directly mounted to the component side of the socket PCB. This is used to calibrate out the fixture contribution. The materials for the fixture must match the materials used in the processor. Note the probe pad features exist on the topside of the top fixture, and the shorting plane exists only on the bottom side of the bottom fixture. Figure 4-5 presents the inductance and capacitance fixture design.

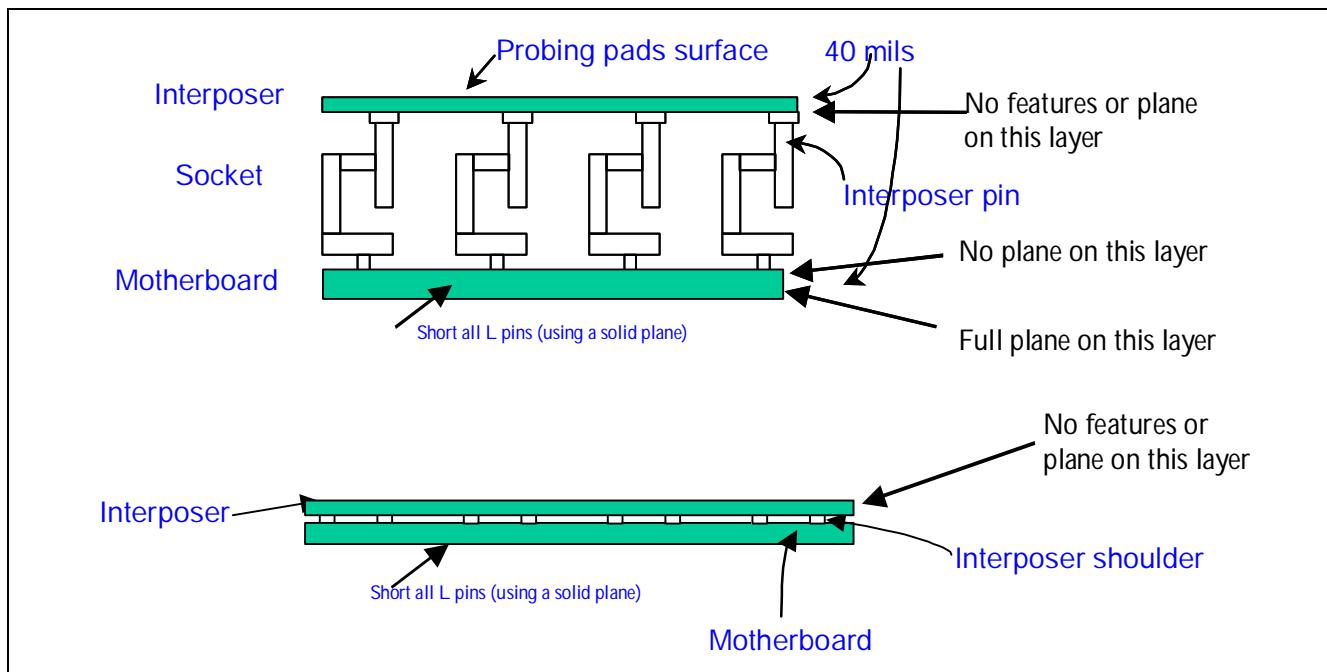


Figure 4-4: Inductance Measurement Fixture Cross-Section

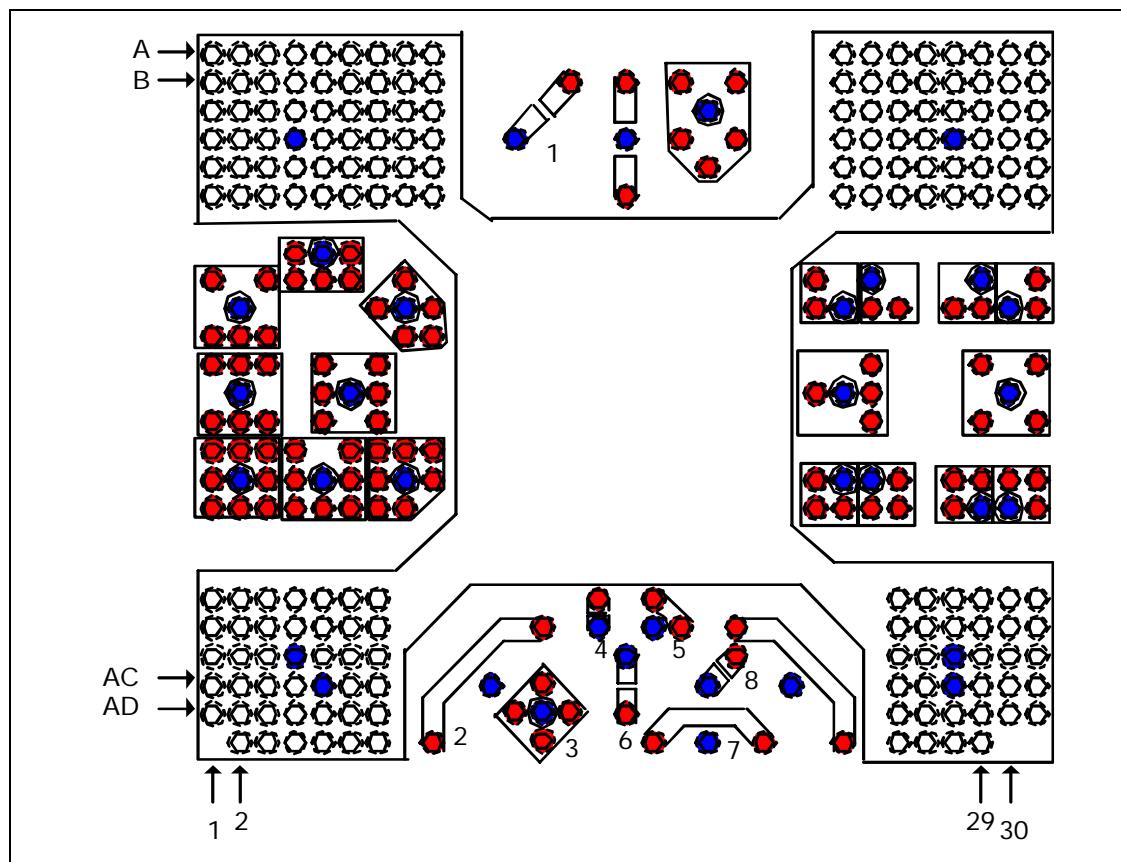


Figure 4-5: Inductance and Capacitance Fixture

4.3.1. Design Procedure for Inductance Measurements:

The measurement equipment required to perform the validation is:

- Equipment - HP8753D Vector Network Analyzer or equivalent
- Robust Probe Station (GTL4040) or equivalent
- Probes - GS1250 & GSG1250 Air-Co-Planar or equivalent
- Calibration – Cascade Calibration Substrates or equivalent
- Measurement objects - Interposers, Sockets, Motherboards

Measurement Steps:

- a) *Equipment setup*
 1. Cables should be connected to the network analyzer and to the probes using the appropriate torque wrench to ensure consistent data collection every time the measurement is performed.
- b) *Set VNA*
 1. Bandwidth = 300KHz – 3GHz with 801 points
 2. Averaging Factor = 16
- c) *Perform Open/Short/Load calibration*
 1. Calibration should be performed at the start of any measurement session.
 2. Create Calibration Kit if necessary for 1st time
 3. Do not perform port extension after calibration
- d) *Check to ensure calibration successfully performed*
- e) *Measure the inductance of configuration 4 of the interposer mounted on the socket, which is mounted to the motherboard fixture (Figure 4-5).*
 1. Call this $L_{\text{socket assembly}}$.
 2. Export data into MDS/ADS or (capture data at frequency specified in item 6 of Table 4.1)
- f) *Measure the inductance of configuration 4 of the interposer mounted on the socket, which is mounted to the motherboard fixture (Figure 4-5). Call this L_{sandwich} .*
 1. Measure 30 units.
 2. The interposer for 30 units must be chosen from different lots. Use 5 different lots, 6 units from each lot.
 3. Export data into MDS/ADS or (capture data at frequency specified in item 6 of Table 4.1).



4. Calculate $\bar{L}_{\text{sandwich}}$.

5. For each socket unit, calculate

$$L_{\text{socket}} = L_{\text{socket assembly}} - \bar{L}_{\text{sandwich}}$$

It means $\bar{L}_{\text{sandwich}}$ will be subtracted from each $L_{\text{socket assembly}}$ and the result will be compared with spec value for each individual socket unit.

4.4. Pin-to-Pin Capacitance:

Pin-to-pin capacitance shall be measured using configuration 4, with the motherboard not connected and only the measurements with the interposer mounted on the socket will be taken. Capture data at frequency specified in item 5 of Table 4-1

4.5. Dielectric Withstand Voltage

No disruptive discharge or leakage greater than 0.5 mA is allowed when subjected to 360 V RMS. The sockets shall be tested according to EIA-364, Test Procedure 20A, Method 1. The sockets shall be tested unmounted and unmated. Barometric pressure shall be equivalent to Sea Level. The sample size is 25 contact to contact pairs on each of 4 sockets. The contacts shall be randomly chosen.

4.6. Insulation Resistance

The Insulation Resistance shall be greater than 800 M Ohm when subjected to 500 V DC. The sockets shall be tested according to EIA-364, Test Procedure 21. The sockets shall be tested unmated and unmounted. The sample size is 25 contact to contact pairs on each of 4 sockets. The contacts shall be randomly chosen.

4.7. Contact Current Rating

Measure and record the temperature rise when the socket is subjected to rated current of 0.8A. The sockets shall be tested according to EIA-364, Test Procedure 70A, Test Method 1. The sockets shall be mounted on a test-board and mated with an interposer so those 370 pins are connected in series. The recommended Test-board is the FSETV4 Rev 1 and the recommended interposer is FSETV5 Rev 1. The wiring list is shown below. Mount the thermocouple as near to contact N3 or N 7 as possible. Short the daisy chains by means of the edge fingers if possible. Sample size is one socket.

Table 4.7.1 Net list for FSETV4 Rev 1 Edge Fingers

Edge Fingers

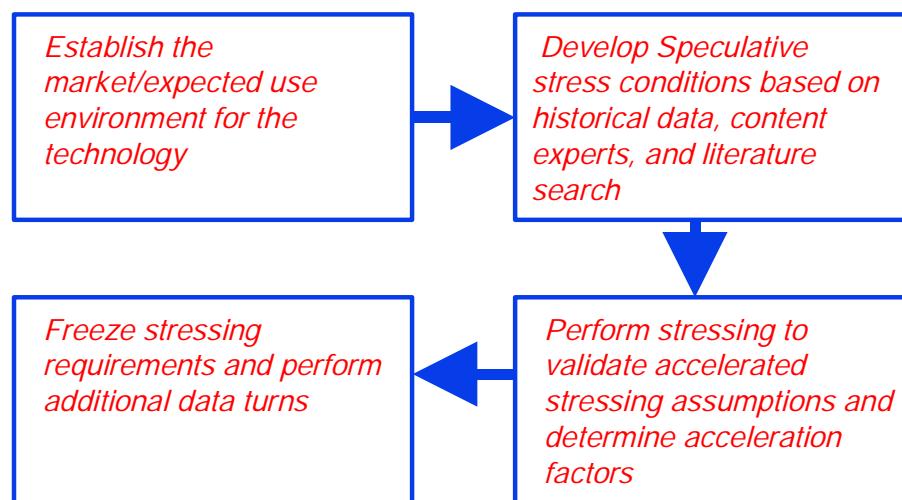
+I: A61	Jumpers:		
-I: A145	A85-A89	A45-A17	A135-A141
	A59-A57	A129-A133	A7-A5
	A87-A95	A15-A13	A139-A143
	A49-A47	A131-A137	A3-A1
	A101-A99	A11-A9	

5. Environmental Requirements

Design, including materials, shall be consistent with the manufacture of units that meet the following environmental reference points.

The reliability targets in this section are based on the expected field use environment for a desktop product. The test sequence for new sockets will be developed using the knowledge-based reliability evaluation methodology, which is acceleration factor dependent. A simplified process flow of this methodology can be seen in Figure 5-1.

Figure 5-1: Flow chart of Knowledge-based Reliability Evaluation Methodology



A detailed description of this methodology can be found at:

<http://developer.intel.com/design/packtech/245162.htm>.

The use environment expectations assumed are for desktop processors, based on an expected life of 7 to 10 years, are listed in Table 5-1. The target failure rates are <1% at 7 years and <3% at 10 years.

Table 5-1: Use conditions environment

Use Environment	Speculative Stress Condition	7 year life expectation	10 year life expectation
Slow small internal gradient changes due to external ambient (temperature cycle or externally heated)	Temperature Cycle	1500 cycles with a mean $\Delta T = 40^{\circ}\text{C}$	2150 cycles with a mean $\Delta T = 40^{\circ}\text{C}$
High ambient moisture during low-power state (operating voltage)-	THB / HAST	62,000 hrs at 30°C , 85%RH	89,000 hrs at 30°C , 85%RH
High Operating temperature and short duration high temperature exposures	BAKE	62,000 hrs at $T_{j\max}$	89,000 hrs at $T_{j\max}$
Fast, large gradient on/off to max operating temp. (power cycle or internally heated including power save features)	Power Cycle	7,500 cycles	11,000 cycles



Use Environment	Speculative Stress Condition	7 year life expectation	10 year life expectation
Shipping & Handling	Mechanical Shock 50g trapezoidal profile; 170°/sec Velocity change; 11 msec duration pulse	3 drops / axis 6 axis	
Shipping & Handling	Random Vibration 3.13 gRMS, random, 5 Hz - 20 Hz .01 g2/Hz sloping up to .02 g2/Hz 20 Hz - 500 Hz .02 g2/Hz	10 min / axis, 3 axis	

5.1. Porosity Test

5.1.1. Porosity Test Method:

Use EIA 364, Test Procedure 53A, Nitric acid test. Porosity test to be performed for 20 contacts, randomly selected per socket, 5 sockets.

5.1.2. Porosity Test Criteria:

Maximum of two pores per set of 20 contacts, as measured per EIA 364, Test Procedure 60.

5.2. Plating Thickness

Measure various plating thickness on contact surface per EIA 364, Test Procedure 48, Method C or Method A. Test to be performed using 20 randomly selected contacts per socket, 5 sockets. No plating thickness measured shall be less than the minimum plating thickness specified in Sections 3.3.4.3.

5.3. Solvent Resistance

Requirement: No damage to ink markings if applicable. EIA 364-11A

5.4. Solderability

(Applicable for leaded sockets) Requirement: 95% coverage per ball/surface mount feature. EIA 364, Test Procedure 52, Class 2, Category 3. Test to be performed on 20 randomly selected contacts per socket, 5 sockets.

5.5. Durability

Use per EIA 364, test procedure 09B. Same package pin field to be used for 1st and 51st cycles. Measure contact resistance when mated in 1st and 51st cycles. A spare package pin field is used for 2nd through 50th cycles. A pair of new package pin fields to be used for each of the socket samples. The package should be removed at the end of each de-actuation cycle and reinserted into the socket.

6. Validation Testing Requirements

This section of the document outlines the tests that must be successfully completed in order for the supplier's socket to pass the design guidelines validation. It provides the test plan and procedure required for validation.

6.1. Applicable Documents:

EIA-364-C.

Intel® Xeon™ Processor at 1.40 GHz, 1.50 GHz and 1.70 GHz¹ (datasheet)

Intel® Xeon™ Processor Thermal Design Guidelines¹

Note: (note 1) For details on ordering this documentation, visit Intel's website at <http://www.intel.com> or contact your Intel field sales representative.

6.2. Testing Facility:

Testing will be performed by Intel's designated test facility.

6.3. Funding:

Socket supplier will fund socket validation testing for their socket. Any additional testing that is required due to design modifications will also be at the expense of the supplier.

6.4. Socket Design Verification:

At the earliest possible date, a detailed drawing of the socket supplier's 603 Pin Socket must be provided to Intel for review. This drawing should include all of the features called out in this design guideline (marking, pinout, cam location, date code location and explanation, etc.) as well as dimensional and board layout information. This drawing will be used to confirm compliance to this design guideline.

6.5. Reporting:

Test reports of the socket validation testing will be provided directly from the independent test facility to Intel. Intel will also be given access to contact the test facility directly to obtain socket validation status, explanation of test results and recommendations based on the test results.

6.6. Process Changes:

Any significant change to the Socket will require submission of a detailed explanation of the change at least 60 days prior to the planned implementation. Intel will review the modification and establish the necessary re-validation procedure that the socket must pass. Any testing that is required MUST be completed before the change is implemented.



Typical examples of significant changes include, but are not limited to, the following: Plastic material changes including base material or color; contact changes including base material, plating material or thickness; and design modifications.

6.7. Quality Assurance Requirements:

The OEM's will work with the socket supplier(s) they choose to ensure socket quality.

6.8. Socket Test Plan:

6.8.1. Submission of a 603 Pin Socket for Socket Validation Testing:

The socket supplier's 603 Pin Socket will be sent to Intel's independent test facility for socket validation testing. The sockets submitted must be per the drawing required in Section 6.4. Refer to Sections 6.11 and 6.12 for production lot definition and number of samples required for validation testing.

6.9. Mechanical Samples:

A mechanical sample of 603 Pin Socket, package, and heat sink (or suitable mockups that approximate size and mass of the planned heat sink) will be used during the mated socket validation testing. The recommended maximum mass for 603 Pin Socket package heat sink is 450 g. See data sheet and related documentation for further information on heat sinks, thermal solutions and mechanical support.

6.10. Socket Validation Notification:

Upon completion of the testing and receipt of test data, Intel and/or the Intel designated test facility will prepare a summary report for the socket supplier and Intel that will provide notification as to whether the socket has passed or failed socket validation testing.

6.11. Production Lot Definition:

A production lot is defined as a separate process run through the major operations including molding, contact stamping, contact plating and assembly. These lots should be produced on separate shifts or days of the week. Lot identification marking needs to be provided to Intel as verification of this process.

6.12. Socket Validation:

Socket validation must meet or exceed all guidelines called out in this spec which include: Visual Inspection, CTF Dimensional Verification, Electrical Resistance, Loop Inductance, Pin to Pin Capacitance, Contact Current Rating, Dielectric Withstand Voltage, Insulation, Durability, Porosity, Plating Thickness, Solvent Resistance (If Applicable), Solderability (Applicable for leaded sockets), Post Reliability Visual and use conditions. The use conditions target failure rates are <1% at 7 years and <3% at 10 years. Statistical sample sizes, taken randomly from multiple lots, for each test is required.

7. Safety Requirements

Design, including materials, shall be consistent with the manufacture of units that meet the following safety standards:

- UL 1950 most current editions
- CSA 950 most current edition
- EN60 950 most current edition and amendments
- IEC60 950 most current edition and amendments



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8. Documentation Requirements

The socket supplier shall provide Intel with the following documentation:

- Multi-Line Coupled SPICE models for socket.
- Product design guideline incorporating the requirements of these design guidelines.
- Recommended board layout guidelines for the socket consistent with low cost, high volume printed circuit board technology.

The test facility shall provide Intel and the supplier with the following document:

- Validation Testing and Test Report supporting successful compliance with these design guidelines.



9. Appendixes

9.1. Appendix A

Figure 9-1. - Appendix A.1 Interposer pin array

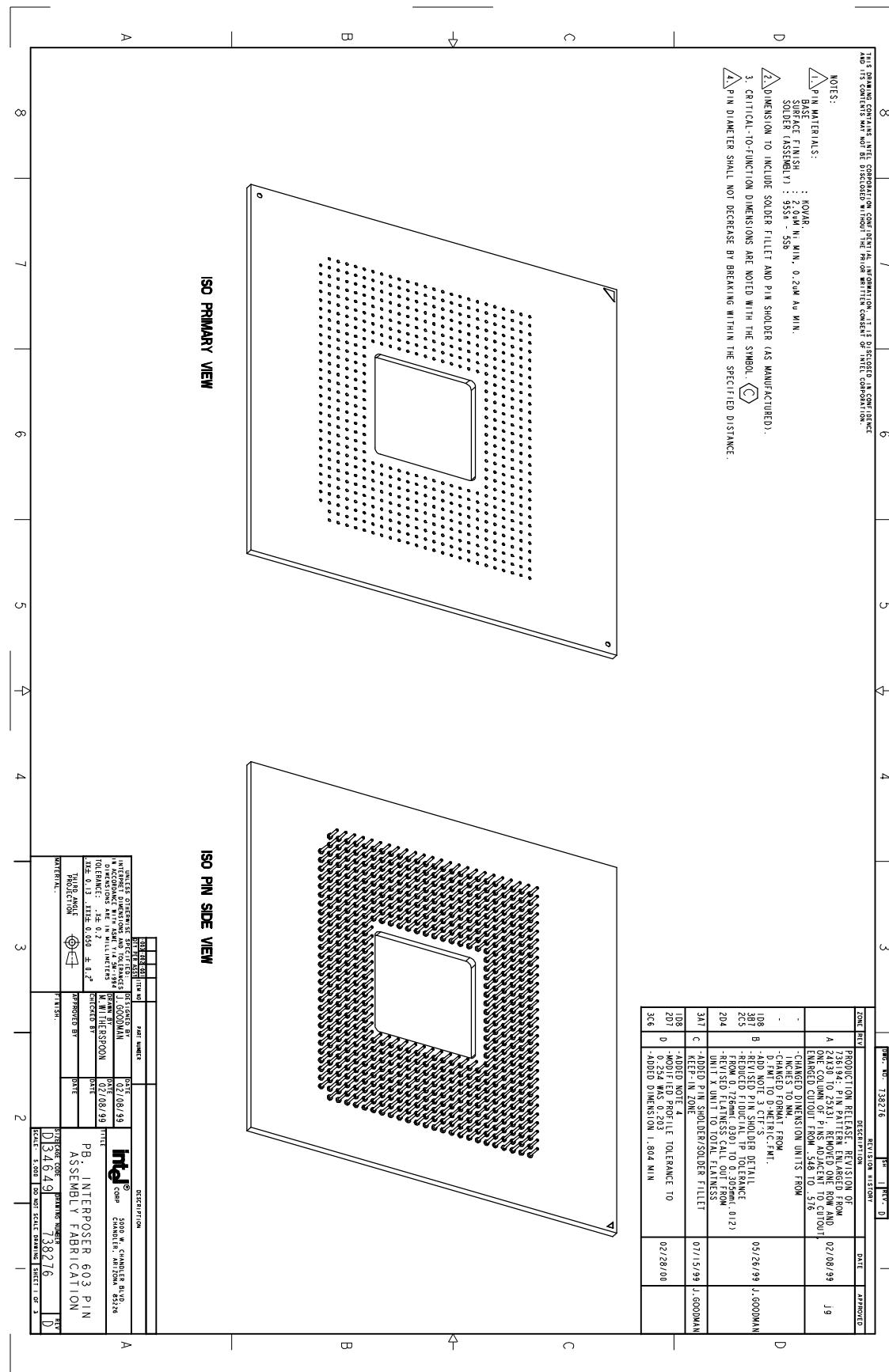


Figure 9-2. - Appendix A.2 Interposer drawing

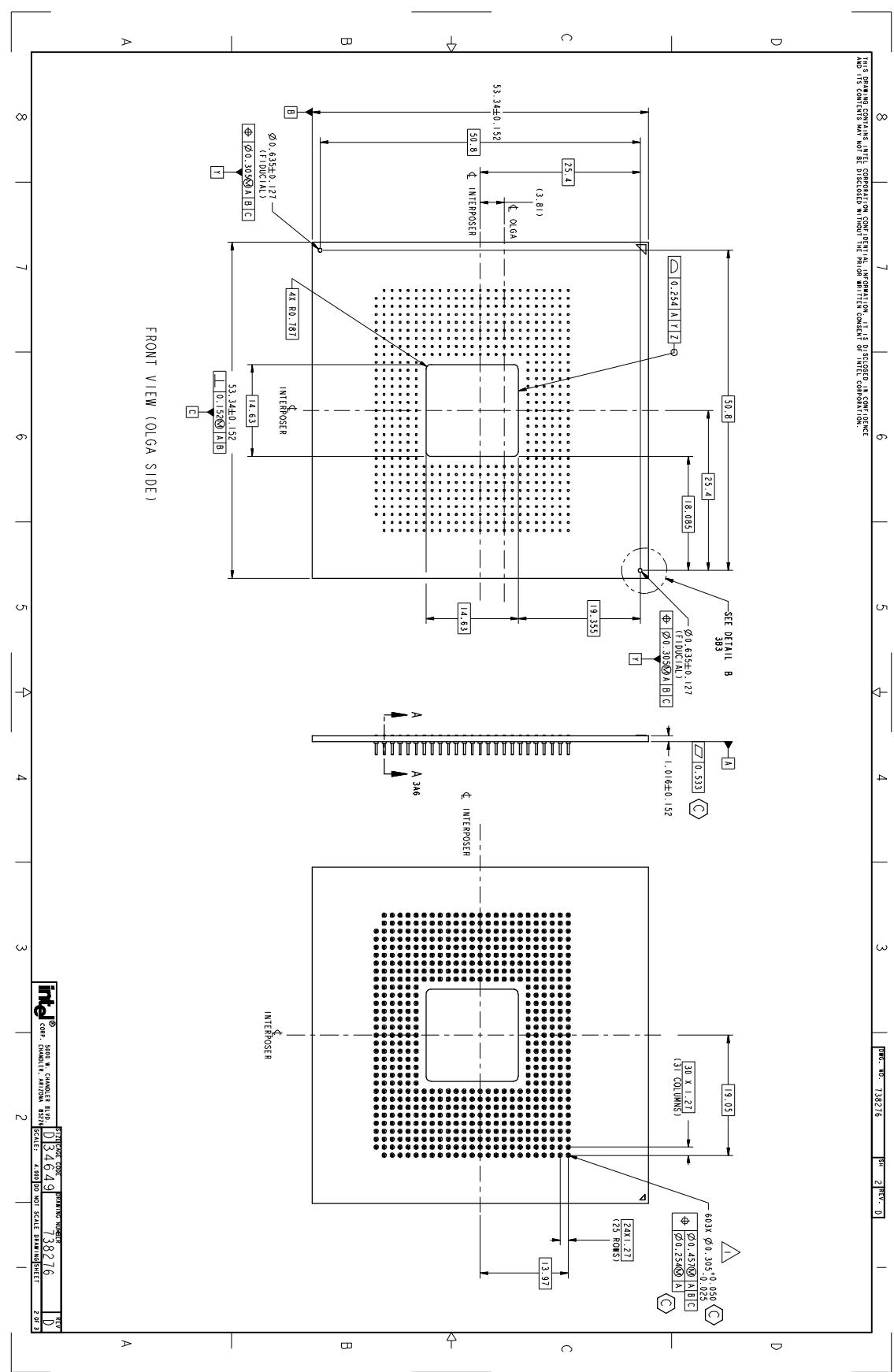


Figure 9-3. - Appendix A.3 603 Pin Processor pin field Pin Details

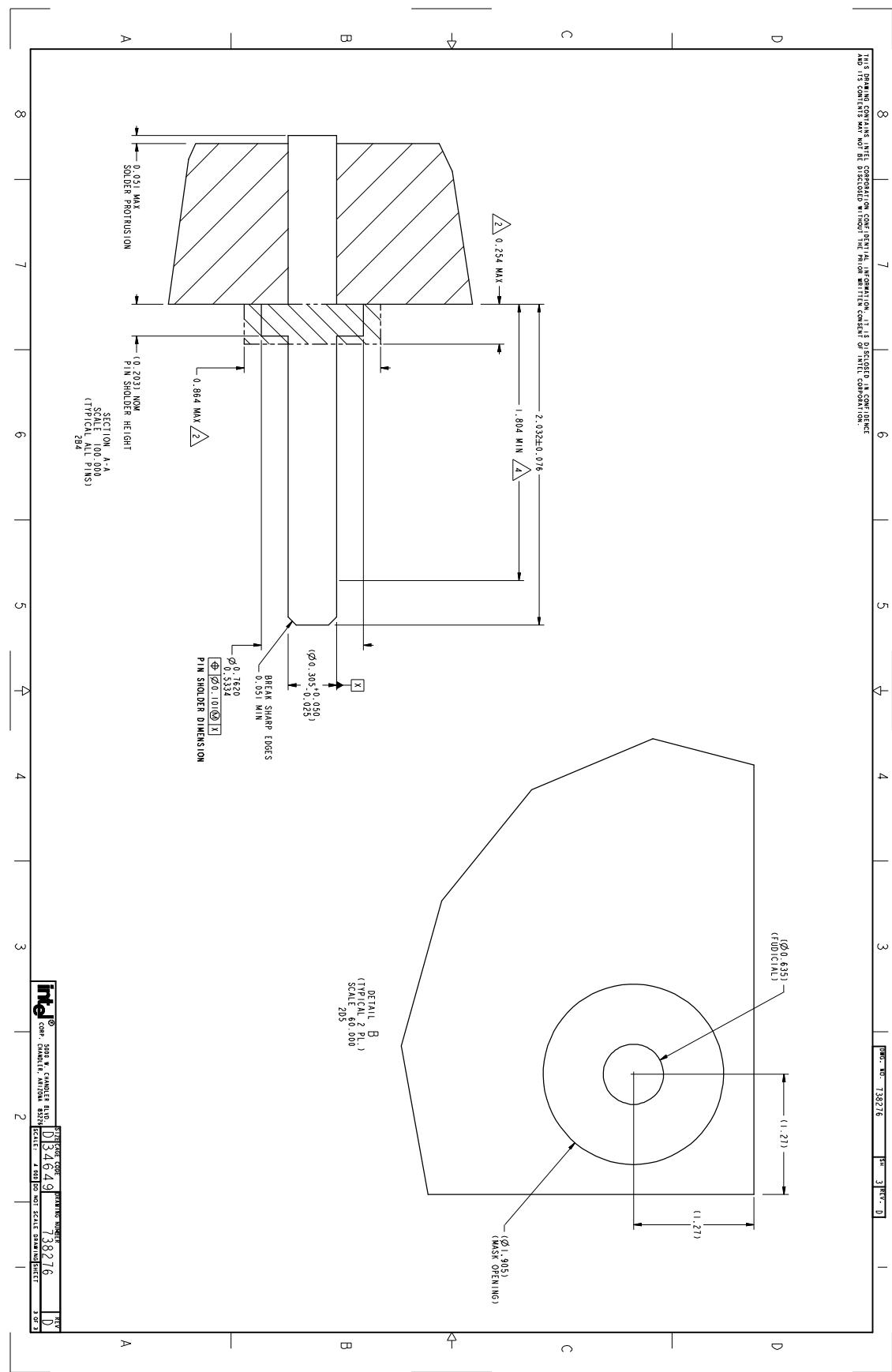
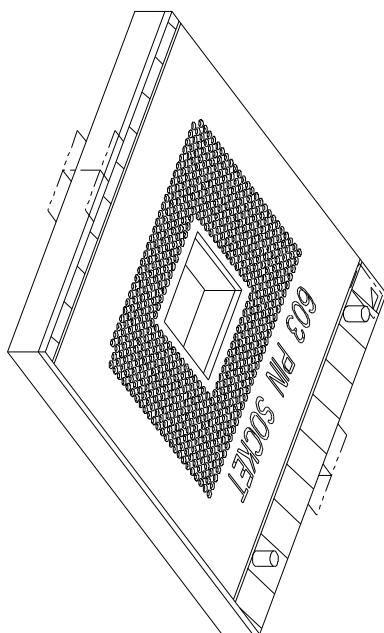


Figure 9-4. - Appendix A.4 Socket Drawing

THIS DRAWING IS FOR INFORMATIONAL PURPOSES ONLY AND IS SUBJECT TO APPROVAL BY THE PHOTOWRITER CONTRACTOR.			
NOTES:			
1. THE PURPOSE OF THIS DRAWING IS TO ESTABLISH THE MECHANICAL FORM OF THE SOCKET. DRAWINGS NOT INTENDED TO SHOW INTERNAL DETAILS OF SOCKET WHICH MAY VARY FROM SUPPLIER TO SUPPLIER.			
2. KEEP IN FOR OPTIONAL FEATURES.			
0 HEIGHT PREFERRED. 1.37 MAX HEIGHT ALLOWED.			
ZONE REF	PRODUCTION RELEASE	REVISION NUMBER	DATE APPROVED
A	ADDED DETAIL A, ADD DEPTH TAILOUT B 0.24 HOLE, ADD COUNTERBORE C CALLOUT WITH GEOMETRIC TOLERANCE	08/12/99	08/12/99
D	ADDED SHEET 2, MOVED DRAWING DETAILS D ADD NOTES 2, 3 AND RELATED COSMETIC FEATURES	10/16/99	
E	ADDED ALIGNMENT POSTS 15 AND TOLERANCES E TAKE ALL HOLE DIA'S AND TOLERANCES F REMOVE NOTE 3 G REMOVE NOTE 3	09/27/00	
F	CHANGED OVERALL LENGTH DIMENSION FROM	010/01	
F	6.344 .25 TO 6.37 .25 MAX		



ITEM	REF	QTY	UNIT	ITEM	REF	QTY	UNIT	PART NUMBER	DESCRIPTION
1	101	1	PCB	2	102	1	PCB	100-100000-000	PCB
3	103	1	PCB	4	104	1	PCB	100-100000-001	PCB
5	105	1	PCB	6	106	1	PCB	100-100000-002	PCB
7	107	1	PCB	8	108	1	PCB	100-100000-003	PCB
9	109	1	PCB	10	110	1	PCB	100-100000-004	PCB
11	111	1	PCB	12	112	1	PCB	100-100000-005	PCB
13	113	1	PCB	14	114	1	PCB	100-100000-006	PCB
15	115	1	PCB	16	116	1	PCB	100-100000-007	PCB
17	117	1	PCB	18	118	1	PCB	100-100000-008	PCB
19	119	1	PCB	20	120	1	PCB	100-100000-009	PCB
21	121	1	PCB	22	122	1	PCB	100-100000-010	PCB
23	123	1	PCB	24	124	1	PCB	100-100000-011	PCB
25	125	1	PCB	26	126	1	PCB	100-100000-012	PCB
27	127	1	PCB	28	128	1	PCB	100-100000-013	PCB
29	129	1	PCB	30	130	1	PCB	100-100000-014	PCB
31	131	1	PCB	32	132	1	PCB	100-100000-015	PCB
33	133	1	PCB	34	134	1	PCB	100-100000-016	PCB
35	135	1	PCB	36	136	1	PCB	100-100000-017	PCB
37	137	1	PCB	38	138	1	PCB	100-100000-018	PCB
39	139	1	PCB	40	140	1	PCB	100-100000-019	PCB
41	141	1	PCB	42	142	1	PCB	100-100000-020	PCB
43	143	1	PCB	44	144	1	PCB	100-100000-021	PCB
45	145	1	PCB	46	146	1	PCB	100-100000-022	PCB
47	147	1	PCB	48	148	1	PCB	100-100000-023	PCB
49	149	1	PCB	50	150	1	PCB	100-100000-024	PCB
51	151	1	PCB	52	152	1	PCB	100-100000-025	PCB
53	153	1	PCB	54	154	1	PCB	100-100000-026	PCB
55	155	1	PCB	56	156	1	PCB	100-100000-027	PCB
57	157	1	PCB	58	158	1	PCB	100-100000-028	PCB
59	159	1	PCB	60	160	1	PCB	100-100000-029	PCB
61	161	1	PCB	62	162	1	PCB	100-100000-030	PCB
63	163	1	PCB	64	164	1	PCB	100-100000-031	PCB
65	165	1	PCB	66	166	1	PCB	100-100000-032	PCB
67	167	1	PCB	68	168	1	PCB	100-100000-033	PCB
69	169	1	PCB	70	170	1	PCB	100-100000-034	PCB
71	171	1	PCB	72	172	1	PCB	100-100000-035	PCB
73	173	1	PCB	74	174	1	PCB	100-100000-036	PCB
75	175	1	PCB	76	176	1	PCB	100-100000-037	PCB
77	177	1	PCB	78	178	1	PCB	100-100000-038	PCB
79	179	1	PCB	80	180	1	PCB	100-100000-039	PCB
81	181	1	PCB	82	182	1	PCB	100-100000-040	PCB
83	183	1	PCB	84	184	1	PCB	100-100000-041	PCB
85	185	1	PCB	86	186	1	PCB	100-100000-042	PCB
87	187	1	PCB	88	188	1	PCB	100-100000-043	PCB
89	189	1	PCB	90	190	1	PCB	100-100000-044	PCB
91	191	1	PCB	92	192	1	PCB	100-100000-045	PCB
93	193	1	PCB	94	194	1	PCB	100-100000-046	PCB
95	195	1	PCB	96	196	1	PCB	100-100000-047	PCB
97	197	1	PCB	98	198	1	PCB	100-100000-048	PCB
99	199	1	PCB	100	200	1	PCB	100-100000-049	PCB
101	201	1	PCB	102	202	1	PCB	100-100000-050	PCB
103	203	1	PCB	104	204	1	PCB	100-100000-051	PCB
105	205	1	PCB	106	206	1	PCB	100-100000-052	PCB
107	207	1	PCB	108	208	1	PCB	100-100000-053	PCB
109	209	1	PCB	110	210	1	PCB	100-100000-054	PCB
111	211	1	PCB	112	212	1	PCB	100-100000-055	PCB
113	213	1	PCB	114	214	1	PCB	100-100000-056	PCB
115	215	1	PCB	116	216	1	PCB	100-100000-057	PCB
117	217	1	PCB	118	218	1	PCB	100-100000-058	PCB
119	219	1	PCB	120	220	1	PCB	100-100000-059	PCB
121	221	1	PCB	122	222	1	PCB	100-100000-060	PCB
123	223	1	PCB	124	224	1	PCB	100-100000-061	PCB
125	225	1	PCB	126	226	1	PCB	100-100000-062	PCB
127	227	1	PCB	128	228	1	PCB	100-100000-063	PCB
129	229	1	PCB	130	230	1	PCB	100-100000-064	PCB
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133	233	1	PCB	134	234	1	PCB	100-100000-066	PCB
135	235	1	PCB	136	236	1	PCB	100-100000-067	PCB
137	237	1	PCB	138	238	1	PCB	100-100000-068	PCB
139	239	1	PCB	140	240	1	PCB	100-100000-069	PCB
141	241	1	PCB	142	242	1	PCB	100-100000-070	PCB
143	243	1	PCB	144	244	1	PCB	100-100000-071	PCB
145	245	1	PCB	146	246	1	PCB	100-100000-072	PCB
147	247	1	PCB	148	248	1	PCB	100-100000-073	PCB
149	249	1	PCB	150	250	1	PCB	100-100000-074	PCB
151	251	1	PCB	152	252	1	PCB	100-100000-075	PCB
153	253	1	PCB	154	254	1	PCB	100-100000-076	PCB
155	255	1	PCB	156	256	1	PCB	100-100000-077	PCB
157	257	1	PCB	158	258	1	PCB	100-100000-078	PCB
159	259	1	PCB	160	260	1	PCB	100-100000-079	PCB
161	261	1	PCB	162	262	1	PCB	100-100000-080	PCB
163	263	1	PCB	164	264	1	PCB	100-100000-081	PCB
165	265	1	PCB	166	266	1	PCB	100-100000-082	PCB
167	267	1	PCB	168	268	1	PCB	100-100000-083	PCB
169	269	1	PCB	170	270	1	PCB	100-100000-084	PCB
171	271	1	PCB	172	272	1	PCB	100-100000-085	PCB
173	273	1	PCB	174	274	1	PCB	100-100000-086	PCB
175	275	1	PCB	176	276	1	PCB	100-100000-087	PCB
177	277	1	PCB	178	278	1	PCB	100-100000-088	PCB
179	279	1	PCB	180	280	1	PCB	100-100000-089	PCB
181	281	1	PCB	182	282	1	PCB	100-100000-090	PCB
183	283	1	PCB	184	284	1	PCB	100-100000-091	PCB
185	285	1	PCB	186	286	1	PCB	100-100000-092	PCB
187	287	1	PCB	188	288	1	PCB	100-100000-093	PCB
189	289	1	PCB	190	290	1	PCB	100-100000-094	PCB
191	291	1	PCB	192	292	1	PCB	100-100000-095	PCB
193	293	1	PCB	194	294	1	PCB	100-100000-096	PCB
195	295	1	PCB	196	296	1	PCB	100-100000-097	PCB
197	297	1	PCB	198	298	1	PCB	100-100000-098	PCB
199	299	1	PCB	200	300	1	PCB	100-100000-099	PCB
201	301	1	PCB	202	302	1	PCB	100-100000-100	PCB
203	303	1	PCB	204	304	1	PCB	100-100000-101	PCB
205	305	1	PCB	206	306	1	PCB	100-100000-102	PCB
207	307	1	PCB	208	308	1	PCB	100-100000-103	PCB
209	309	1	PCB	210	310	1	PCB	100-100000-104	PCB
211	311	1	PCB	212	312	1	PCB	100-100000-105	PCB
213	313	1	PCB	214	314	1	PCB	100-100000-106	PCB
215	315	1	PCB	216	316	1	PCB	100-100000-107	PCB
217	317	1	PCB	218	318	1	PCB	100-100000-108	PCB
219	319	1	PCB	220	320	1	PCB	100-100000-109	PCB
221	321	1	PCB	222	322	1	PCB	100-100000-110	PCB
223	323	1	PCB	224	324	1	PCB	100-100000-111	PCB
225	325	1	PCB	226	326	1	PCB	100-100000-112	PCB
227	327	1	PCB	228	328	1	PCB	100-100000-113	PCB
229	329	1	PCB	230	330	1	PCB	100-100000-114	PCB
231	331	1	PCB	232	332	1	PCB	100-100000-115	PCB
233	333	1	PCB	234	334	1	PCB	100-100000-116	PCB
235	335	1	PCB	236	336	1	PCB	100-100000-117	PCB
237	337	1	PCB	238	338	1	PCB	100-100000-118	PCB
239	339	1	PCB	240	340	1	PCB	100-100000-119	PCB
241	341	1	PCB	242	342	1	PCB	100-100000-120	PCB
243	343	1	PCB	244	344	1	PCB	100-100000-121	PCB
245	345	1	PCB	246	346	1	PCB	100-100000-122	PCB
247	347	1	PCB	248	348	1	PCB	100-100000-123	PCB
249	349	1	PCB	250	350	1	PCB	100-100000-124	PCB
251	351	1	PCB	252	352	1	PCB	100-100000-125	PCB
253	353	1	PCB	254	354	1	PCB	100-100000-126	PCB
255	355	1	PCB	256	356	1	PCB	100-100000-127	PCB
257	357	1	PCB	258	358	1	PCB	100-100000-128	PCB
259	359	1	PCB	260	360	1	PCB	100-100000-129	PCB
261	361	1	PCB	262	362	1	PCB	100-100000-130	PCB
263	363	1	PCB	264	364	1	PCB	100-100000-131	PCB
265	365	1	PCB	266	366	1	PCB	100-100000-132	PCB
267	367	1	PCB	268	368	1	PCB	100-100000-133	PCB
269	369	1	PCB	270	370	1	PCB	100-100000-134	PCB
271	371	1	PCB	272	372	1	PCB	100-100000-135	PCB
273	373	1	PCB	274	374	1	PCB	100-100000-136	PCB
275	375	1	PCB	276	376	1	PCB	100-10000	

Figure 9-5. - Appendix A.5 Socket Drawing

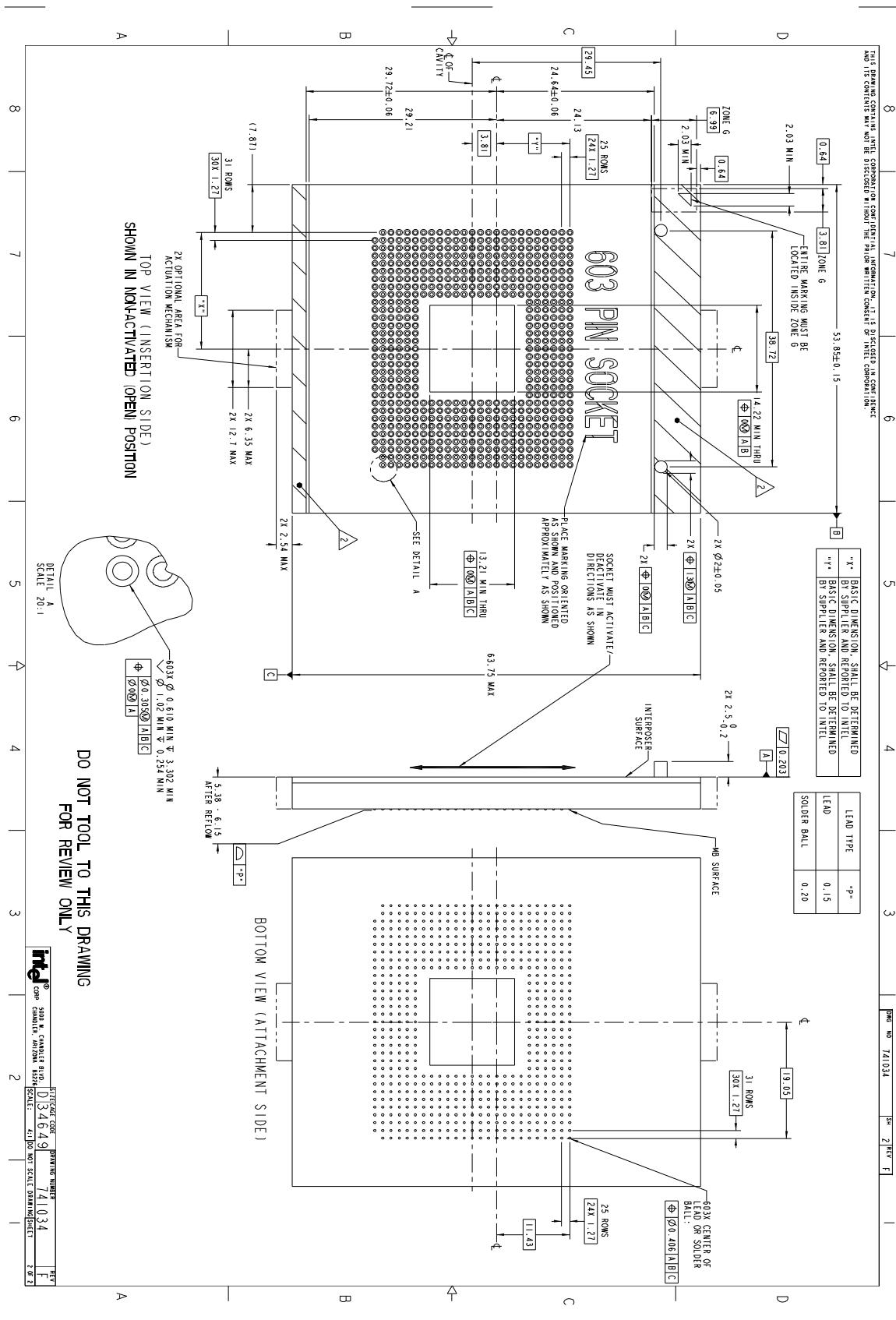


Figure 9-6. - Appendix A.6 603 Pin Socket Keep-In Zone

